

Gain Stabilization of SiPMs

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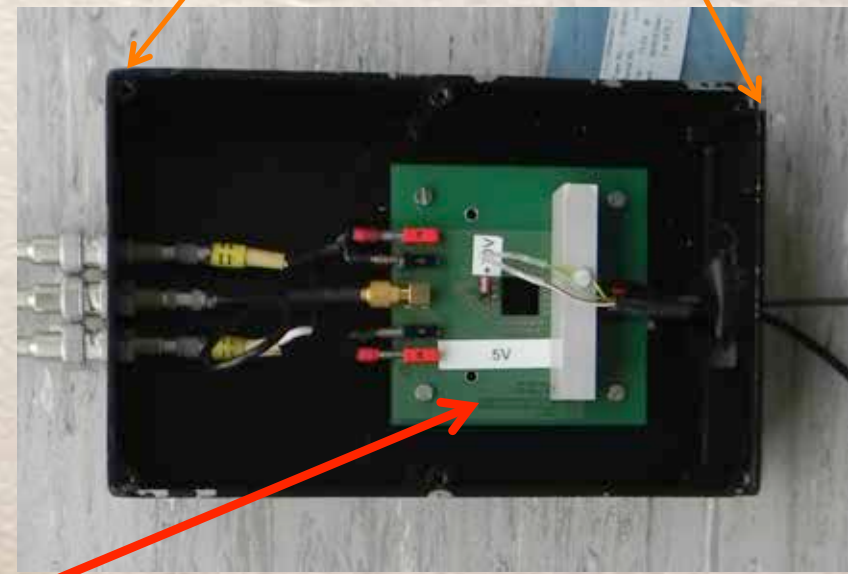
Linear Collider Workshop, Tokyo 13/11/2013

Introduction

- The gain of SiPMs depends both on bias voltage and on temperature
 - Gain decreases with temperature
 - Gain increases with bias voltage
- For stable operations, we need to keep gain constant
- In an analogue hadron calorimeter with millions of channels, this is a difficult task due to temperature variations
- Thus, it is desirable to adjust V_{bias} to compensate for T changes to keep the gain constant
- Goal: build a V_{bias} regulator to keep gain constant (<1%)
- First, we need to measure SiPM gain vs temperature and V_{bias}
 - determine dV/dT to obtain constant gain
 - build V_{bias} regulator test board to demonstrate proof of principle
- This is work conducted in the framework of the EU project AIDA

SiPM Test Setup

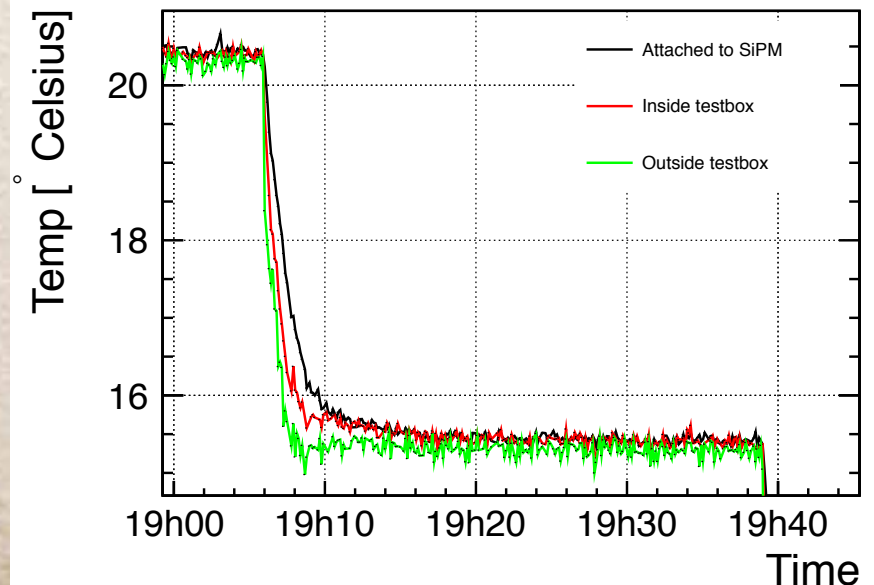
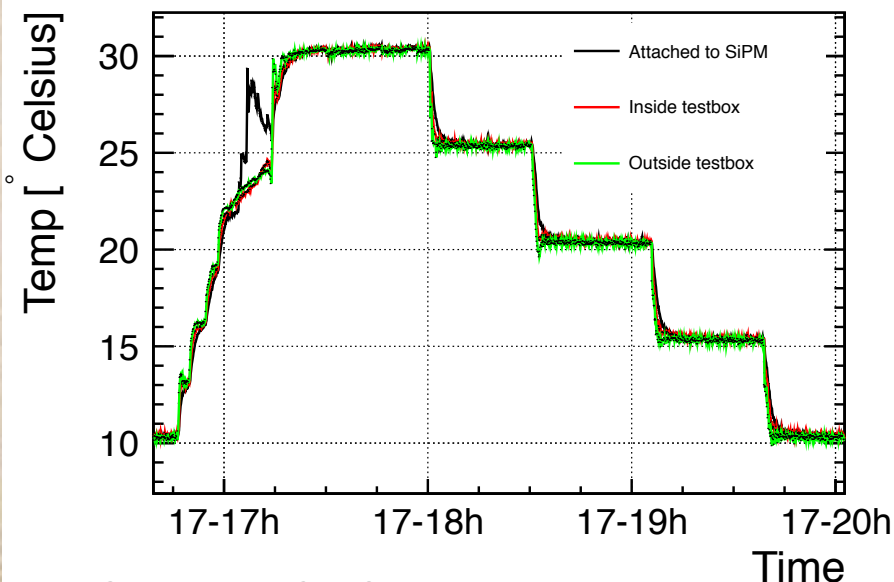
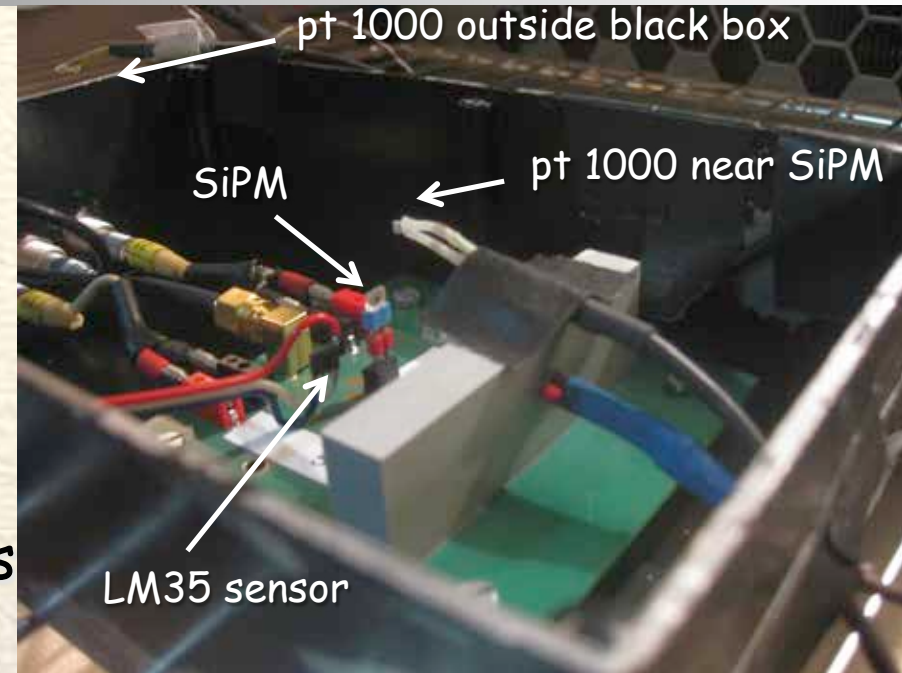
- We work in a climate chamber at CERN that is accurate to 0.1°C
- Use digital oscilloscope read out by PC, low voltage & bias voltage power supplies
- Use pulse generator for LED signal
- Shine blue LED light on detectors



SiPM + preamp + T sensor + LED₃

Temperature Measurement

- Use 3 pt 1000 sensors
 - Near SiPM, inside/outside black box
- Use LM35 sensor to measure T to perform gain correction
- Vary T from 5°C to 40°C in 5°C steps except in 20°-30°C range use 2°C steps
 - $T_{SiPM} \sim T_{SET} + 0.4^{\circ}C$,
 - offset is same over entire range



SiPM Detectors Tested

- We measured the dG/dT & dG/dV dependence for 15 SiPMs from 3 manufacturers

- We tested the V_{bias} adjustment on 4 SiPMs:

- CPTA 857

- CPTA 1677

- KETEK W 12

- Hamamatsu 11759

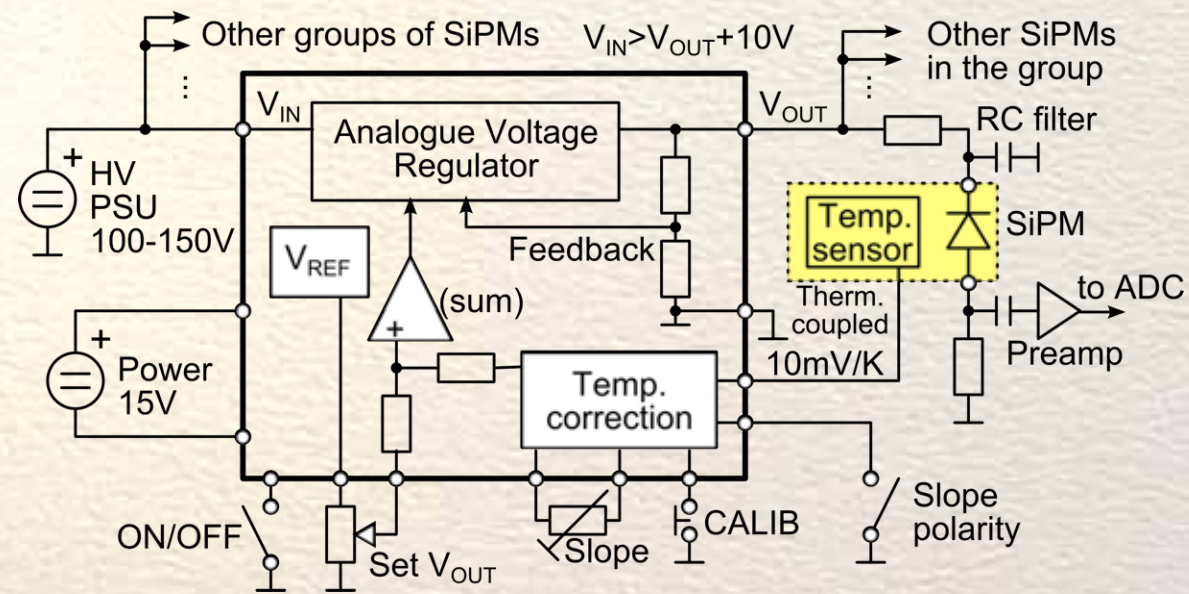
- Note that CPTA sensors were attached to

$3 \times 3 \text{ cm}^2$ scintillator tiles while the other sensors were directly illuminated by blue LED

Manufacturer and Type #	Sensitive area [mm^2]	Pixel pitch [μm]	#pixels	Typical V_{bias} [V]	Typical G [$\times 10^5$]	Serial #
Hamamatsu						
S10943-8584(X)	1×1	50	400	71.69	7.49	11759
S10943-8584(X)	1×1	50	400	71.57	7.49	11766
S10943-8584(X)	1×1	50	400	71.50	7.48	11770
S10943-8584(X)	1×1	50	400	71.33	7.48	11771
Sample A	1×1	20	2500	66.7	2.3	A1
Sample B	1×1	20	2500	73.3	2.3	B1
Sample A	1×1	15	4440	67.2	2.0	A2
Sample B	1×1	15	4440	74.0	2.0	B2
CPTA						
	1×1	40	796	33.4	7.1	857
	1×1	40	796	33.1	6.3	922
	1×1	40	796	33.3	6.3	975
	1×1	40	796	33.1	7.0	1065
	1×1	40	796	33.3	14.6	1677
KETEK						
MP15 V6 ?	$2(1.2 \times 1.2)$	15?	?	-28	?	W8
MP20 V4 ?	3×3	20?	?	-28	?	W12

Layout of the Adaptive Power Regulator

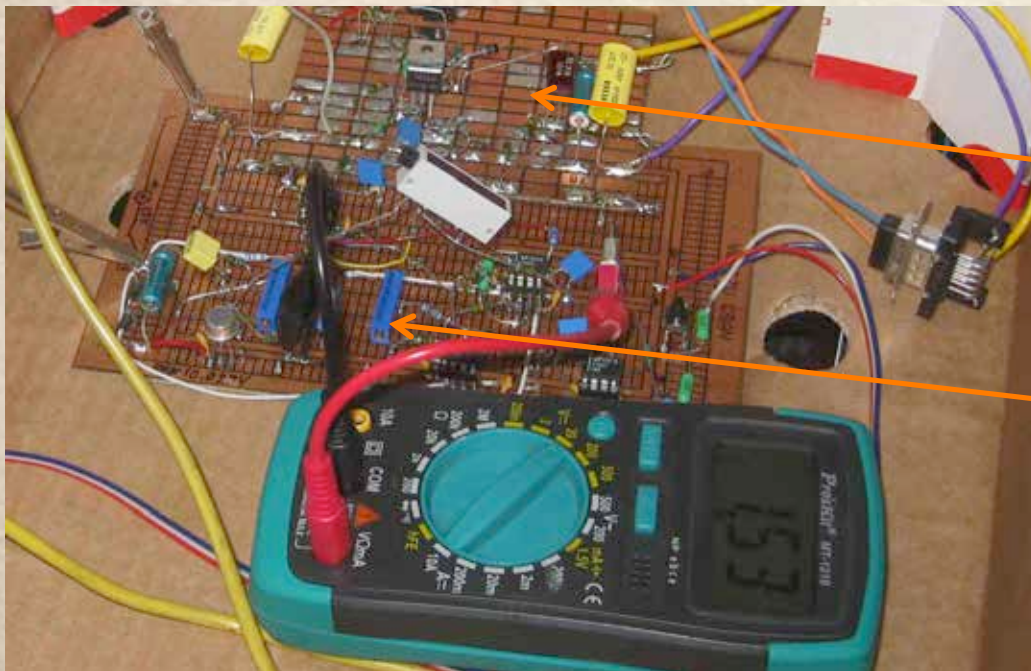
- Design V_{bias} regulator that operates in 10 V to 80 V region plus T correction effects
- Temperature slope: <1 to 100 mV/K, both positive and negative



- First design of test board

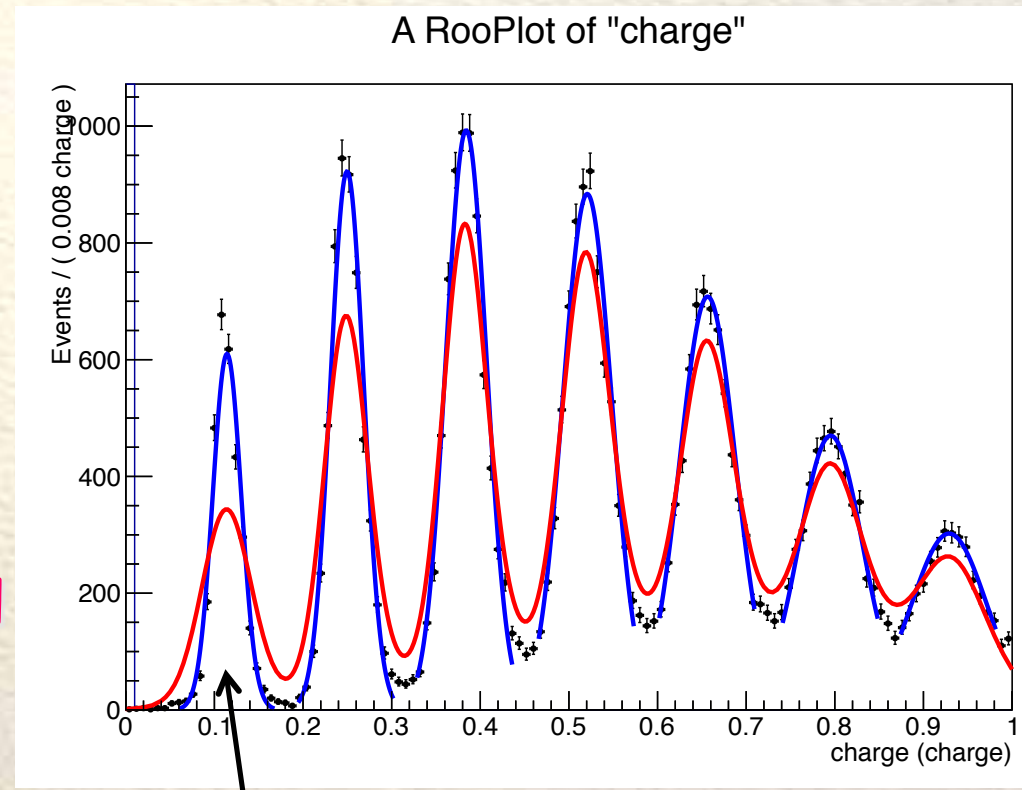
Analogue voltage regulator

Voltage reference



Gain Determination

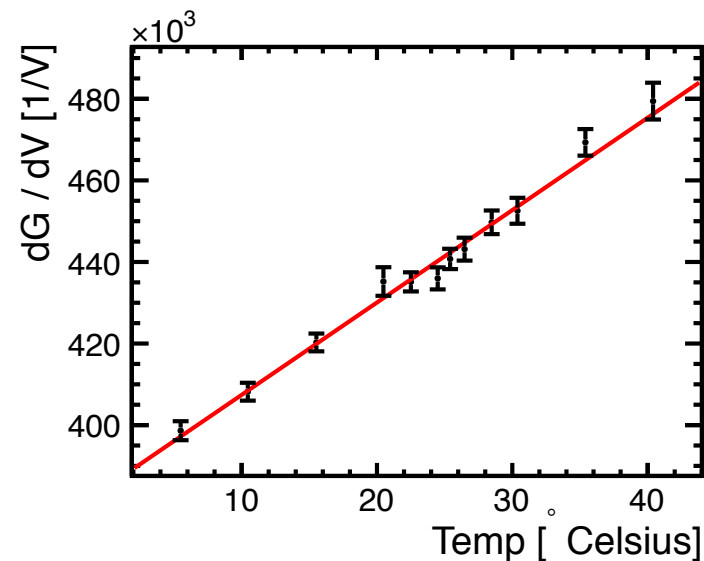
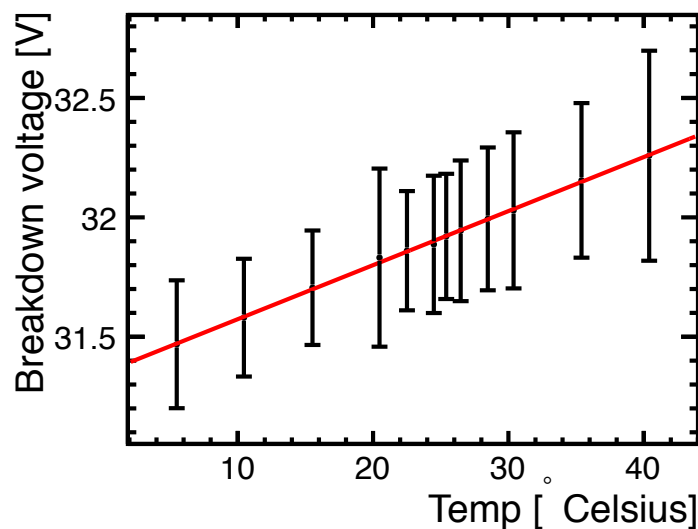
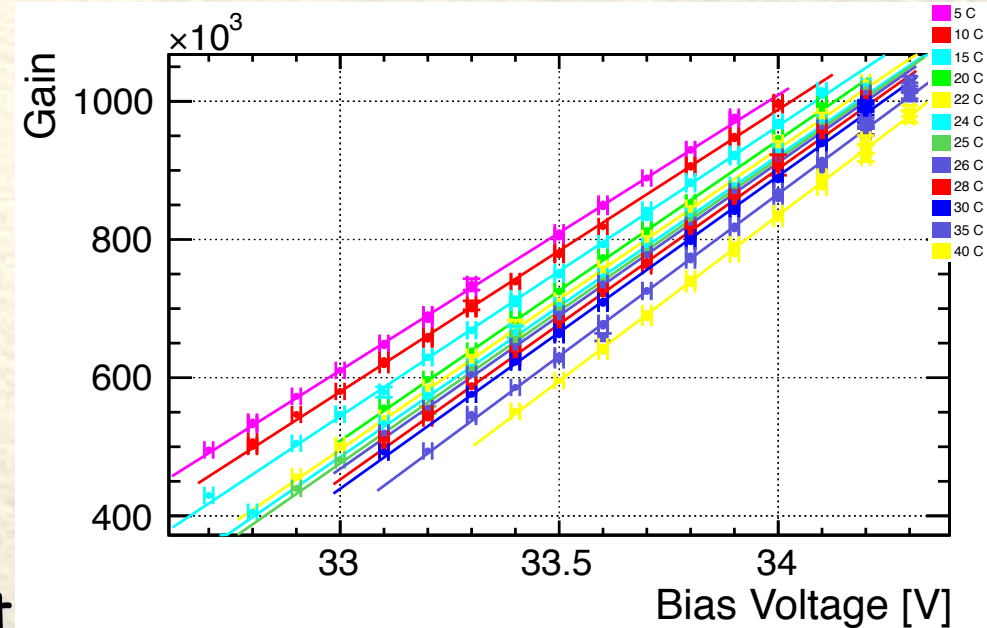
- Determine gain by fitting Gaussian functions to peaks of single pe spectra
- Define gain as
 - Distance between 1 pe & 2 pe peaks (MPPCs)
 - Distance between pedestal 1 pe peak (CPTA, KETEK)
- Define the error on the gain as the errors of the two fitted Gaussian mean values added in quadrature
- Require gain extracted from Gaussian peaks and that from multikernel peaks not to differ by more than 20%



RooFit multikernel function
Individual Gaussian fits

Gain vs Voltage for CPTA 857

- Each point is the gain extracted from 50k waveforms of 80 ns
- Linear fit to these distributions yields break-down voltage & dG/dV
- Break-down voltage drops with T
- $dG/dV \sim$ capacitance is not constant
 → it increases linearly with temperature



Gain vs Temperature for CPTA 857

- At $V_{\text{bias}}=33.4 \text{ V}$ & $T=25^\circ$: $G=6.4 \times 10^5$

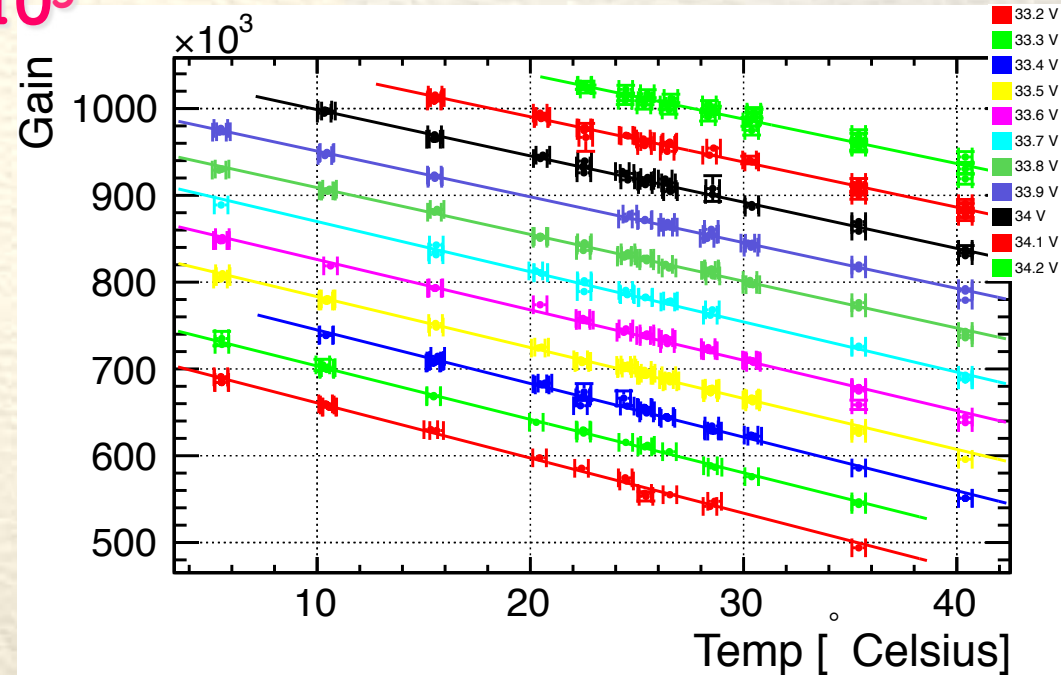
- Extract $V_{\text{breakdown}}=31.9 \text{ V}$

- 0th order polynomial fit yields:

$$dG/dV=(4.32 \pm 0.01_{\text{stat}}) \times 10^5 / \text{K}$$

- 1st order polynomial fit yields:

$$dG/dV=(4.41 \pm 0.11_{\text{sys}}) \times 10^5 / \text{K}$$



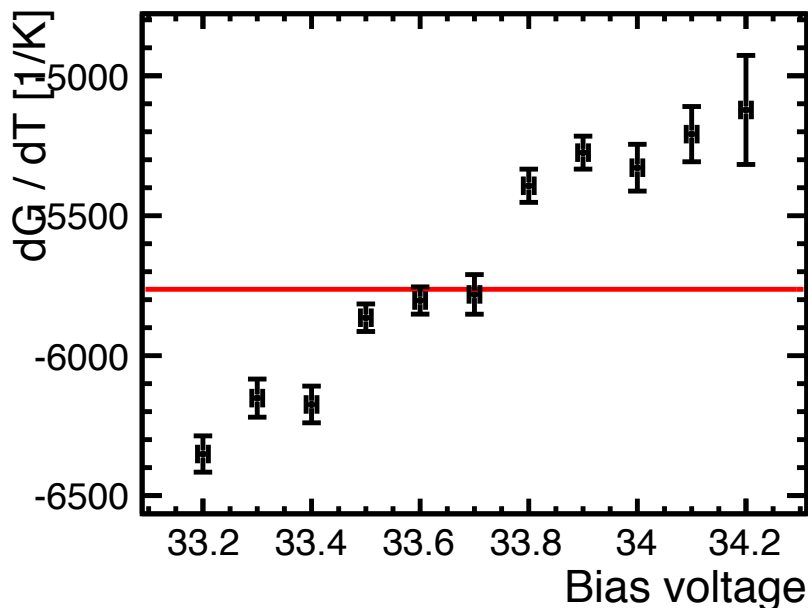
- 0th order polynomial fit yields:

$$dG/dT=(-5.76 \pm 0.02_{\text{stat}}) \times 10^3 / \text{K}$$

- Determine:

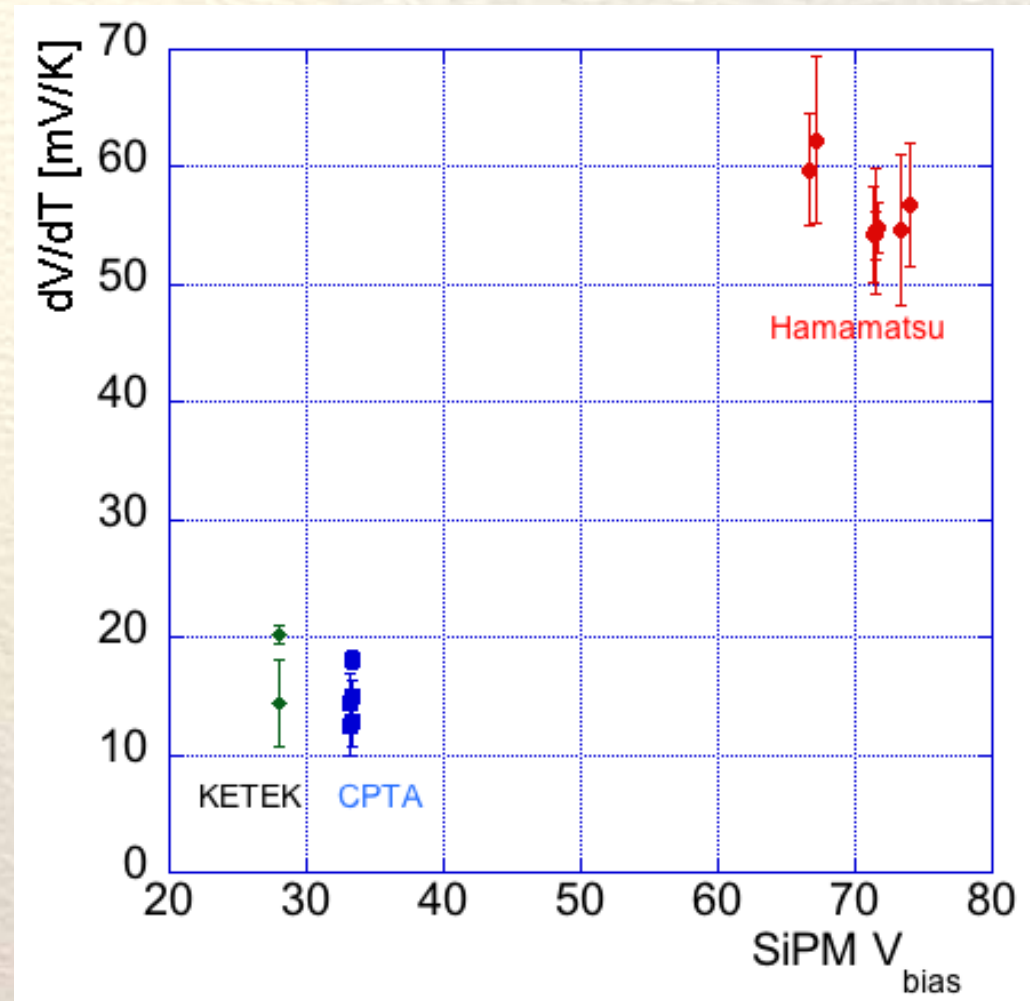
$$dV/dT = \langle dG/dT \rangle / \langle dG/dV \rangle = 13.33 \pm 0.35 \text{ mV/K}$$

- Gain stability = $\sigma(dV/dT) / (2G \cdot dG/dV) = 0.12\%$



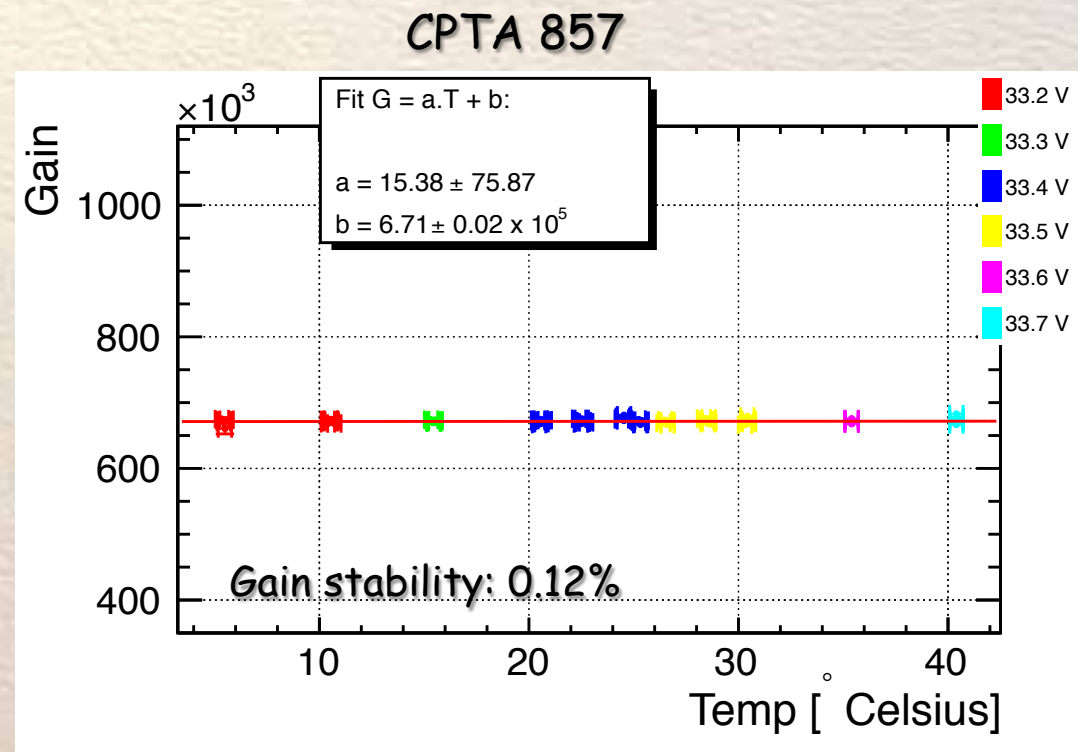
Summary of dV/dT Measurements

- V_{bias} for Hamamatsu is ~ 70 V while V_{bias} for CPTA is ~ 33 V & V_{bias} for KETEK is ~ 28 V
- For KETEK and CPTA, dV/dT is $\sim 15-20$ mV/K for Hamamatsu, dV/dT is ~ 55 mV/K
- Thus, compensation will be simpler for CPTA and KETEK detectors
- We tested the compensation on four detectors so far, including samples from all manufacturers



Gain after V_{bias} Adjustment for CPTA 857

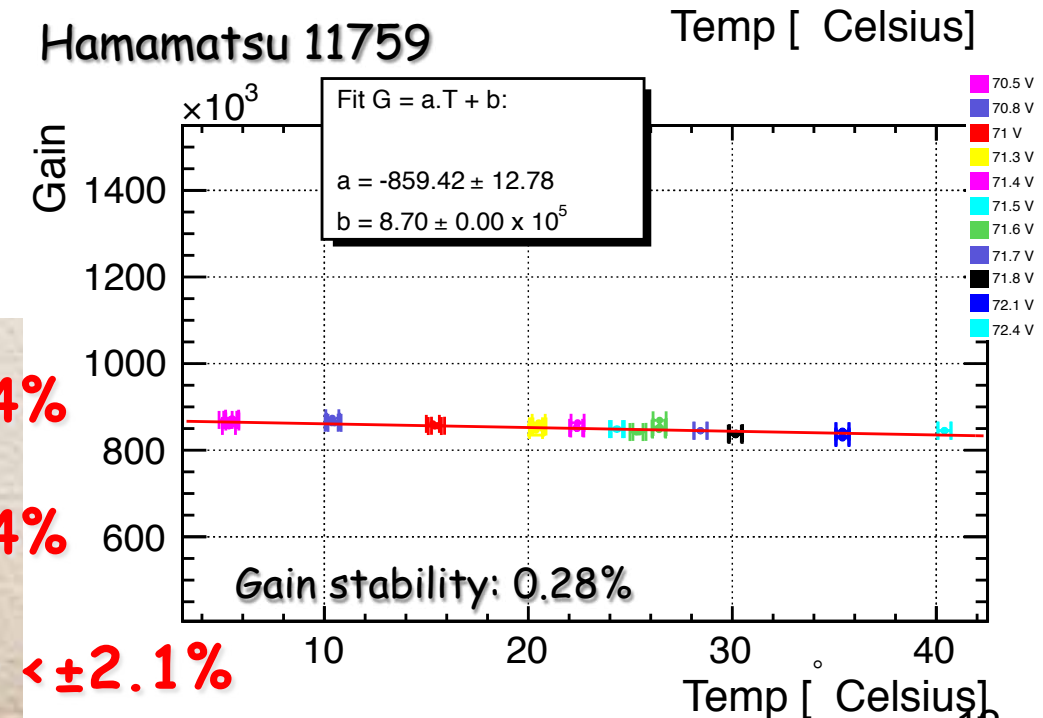
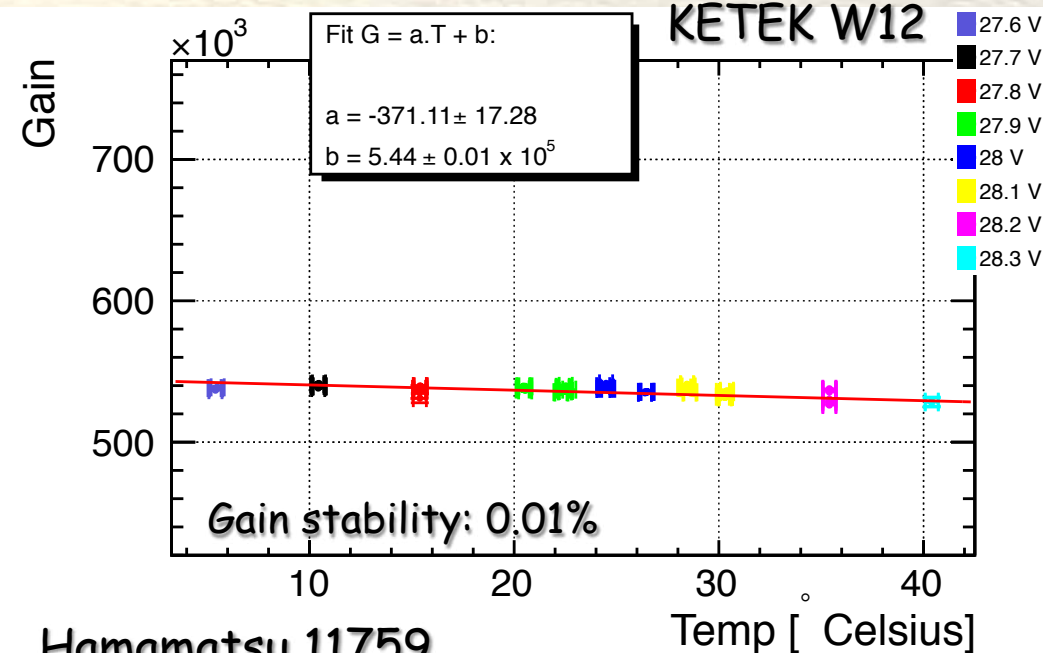
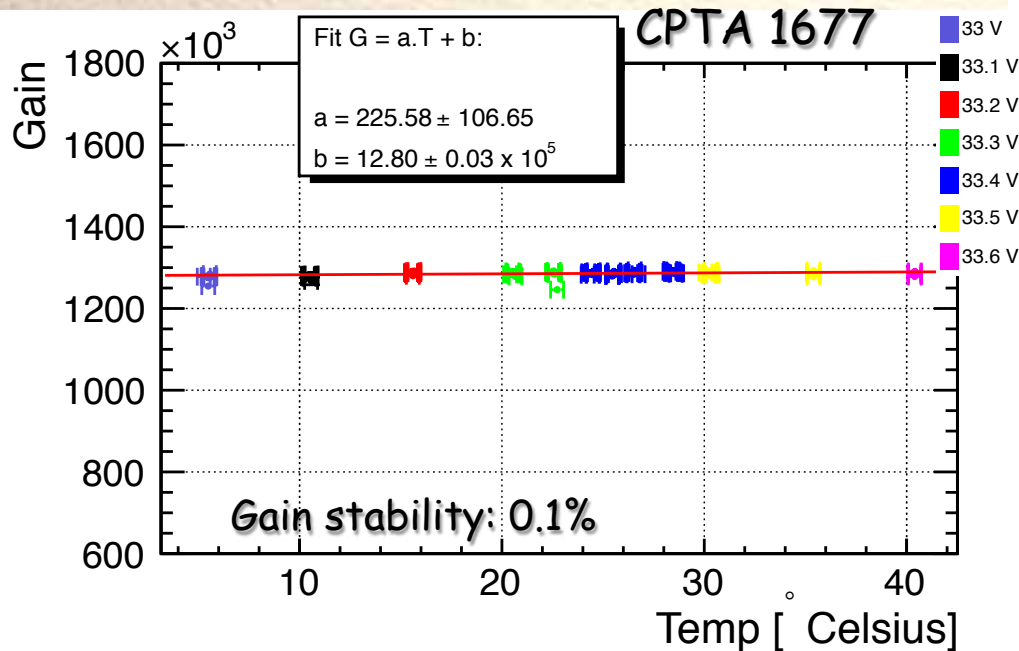
- Adjust voltage continuously using V_{bias} regulator test board
 Note: color code gives the range of voltage applied
 e.g. blue: $33.35 < V_{bias} < 33.45$
- At each temperature, take 16 samples with 50k waveform each
- Linear fit to all data points
 - offset: $(6.71 \pm 0.02) \times 10^5$
 - slope: 15.38 ± 75.87
- Gain is uniform in range of interest $5^\circ - 40^\circ C$
 → measured non-uniformity is $< \pm 0.05\%$





Gain after V_{bias} Adjustment for other SiPMs

- Perform similar study with 3 other SiPMs from CPTA, KETEK and Hamamatsu



- CPTA 1677: non-uniformity $< \pm 0.4\%$
- KETEK W12: non-uniformity $< \pm 1.4\%$
- Hamamatsu 11759: non-uniformity $< \pm 2.1\%$

Voltage Temperature Relation

- dV/dT is obtained from a ratio of 2 first-order differential equations

- $dG/dT = a + b \cdot V + \mathcal{O}(V^2)$

- $dG/dV = c + d \cdot T + \mathcal{O}(T^2)$

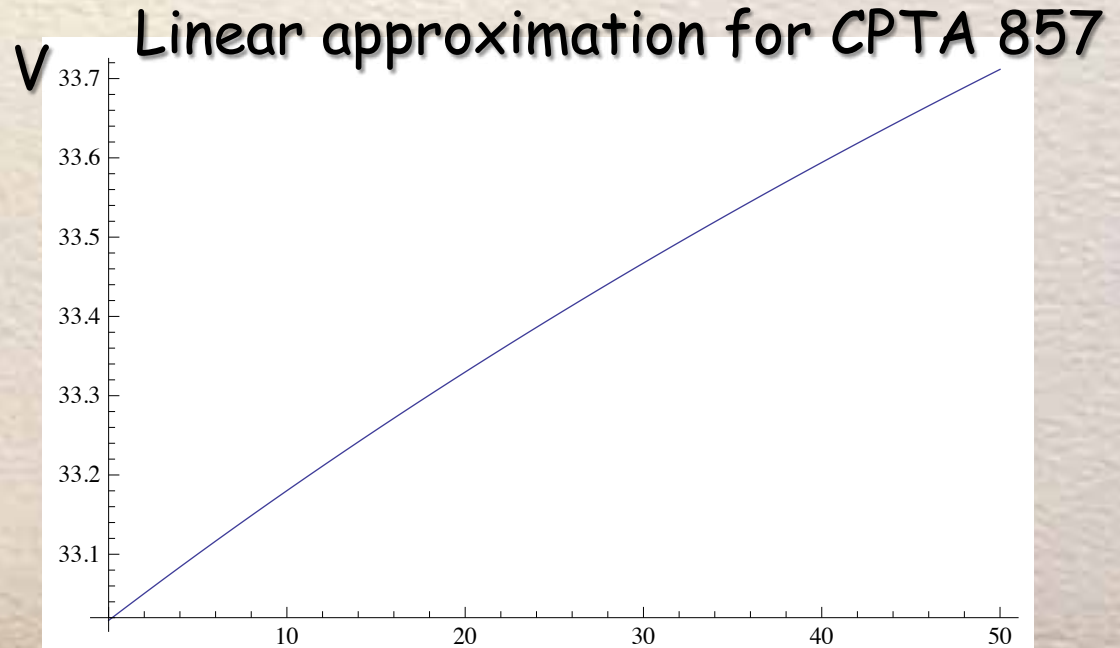
- Thus, an analytical solution exists

- For the above linear case, we get:

- For quadratic case solution is $\sim \text{Atan}[a' + b'T]$

$$V[T] = \frac{a}{c} + \left(c + d \cdot T \right)^{\frac{b}{d}} \quad (d \neq 0)$$

- For a linear model in dG/dT and dG/dV find following V versus T dependence



Conclusion

- Hamamatsu sensors operate at higher V_{bias} than CPTA/KETEK sensors
- dV/dT is similar for CPTA & KETEK sensors (15-20 mV/K) while Hamamatsu sensors yield larger values ~ 55 mV/K
- For CPTA & KETEK (Hamamatsu), the maximum voltage adjustments are less than $\Delta V=0.7$ (1.9) V for range $5^{\circ}\text{C} < T < 40^{\circ}\text{C}$
- The gain stabilization with the V_{bias} regulator prototype works well
→ for all four tested SiPMs, gain stability is **< 1%** as required
- Non-uniformity of gain vs T after compensation is better than
→ **$\pm 1\%$** for CPTA detectors ($5^{\circ}\text{C} < T < 40^{\circ}\text{C}$)
→ **$\pm 2.1\%$ ($\pm 1.4\%$)** for Hamamatsu (KETEK) detectors ($5^{\circ}\text{C} < T < 40^{\circ}\text{C}$)
→ **$\pm 1\%$** for Hamamatsu and KETEK detectors ($20^{\circ}\text{C} < T < 30^{\circ}\text{C}$)
- V versus T dependence has analytical solution, which for linear dG/dT and linear dG/dV is

$$V[T] = \frac{a}{c} + \left(c + d \cdot T \right)^{\frac{b}{d}}$$

Next Steps

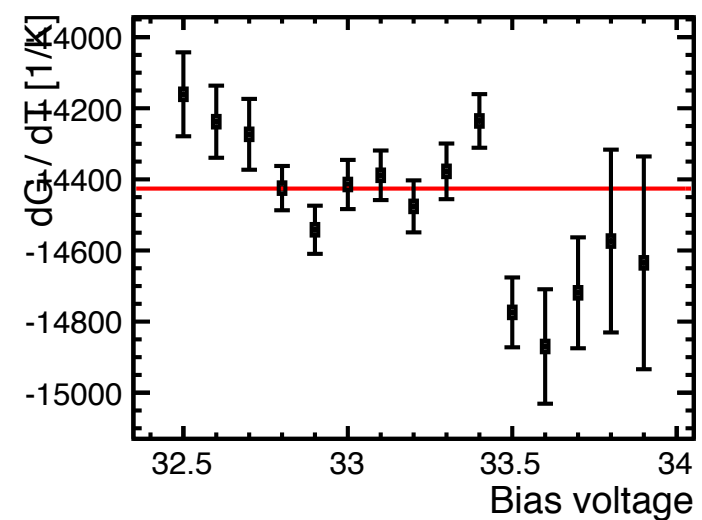
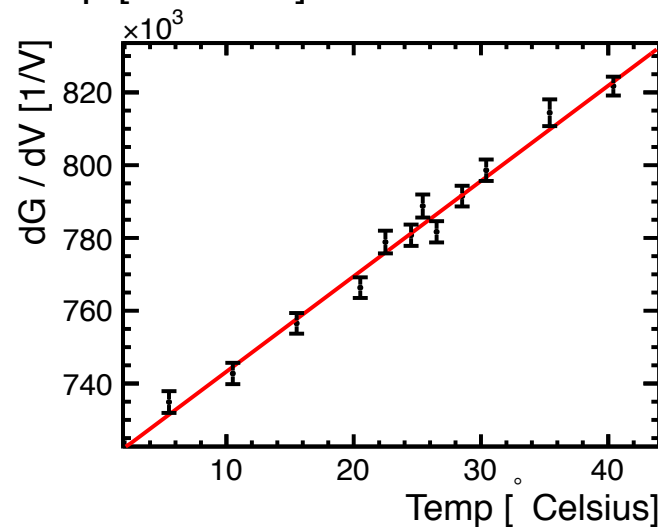
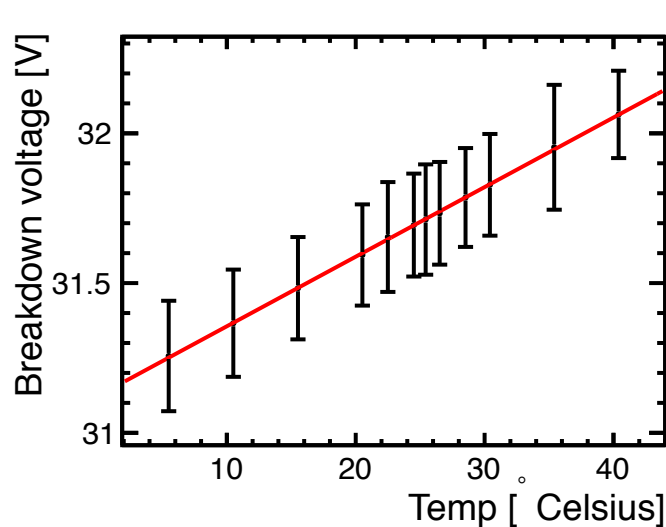
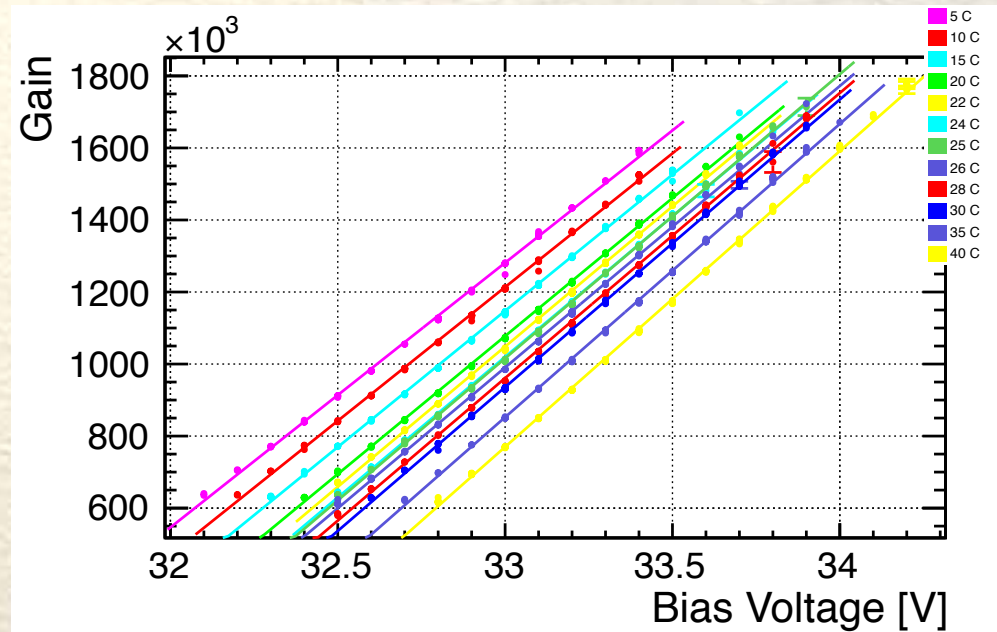
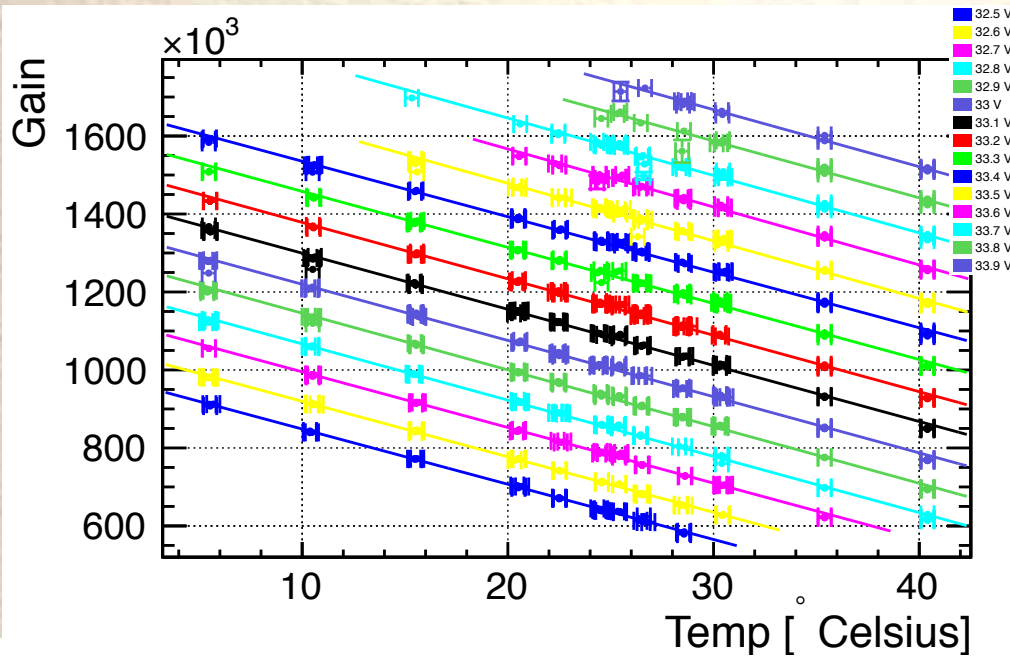
- Test more SiPMs with the V_{bias} test board
- Design V_{bias} regulator PCB → layout is nearly completed
- Produce first V_{bias} regulator PCB prototype → end of 2013
- Test prototype on several SiPMs to come up with the final regulator PCB (ready for mass production) → early 2014
- Integrate the V_{bias} regulator PCB into the FE readout electronics of the AHCAL → summer 2014
- Write final report for AIDA project → fall 2014



Backup Slides

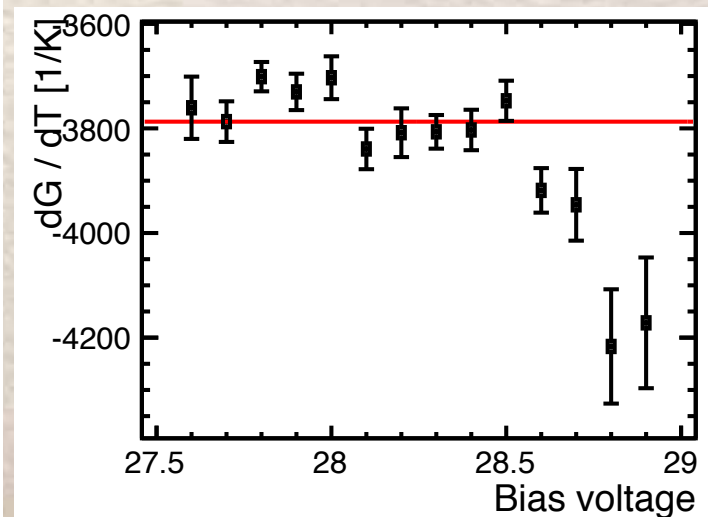
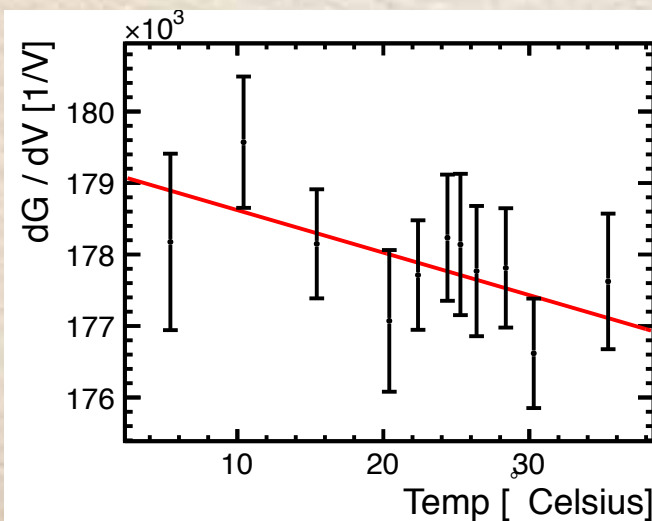
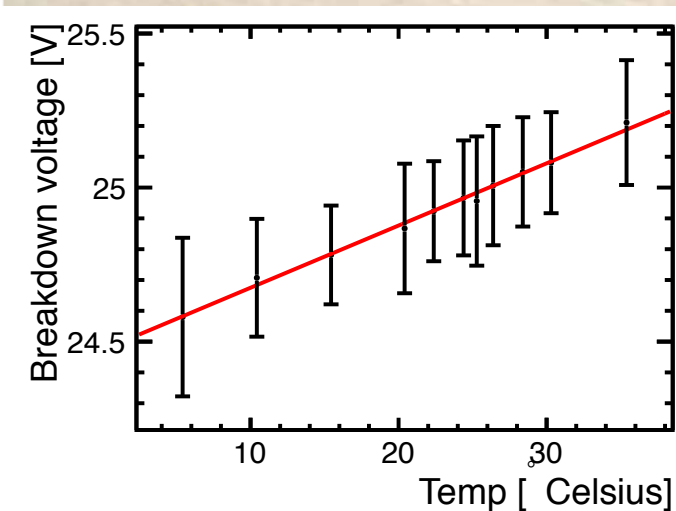
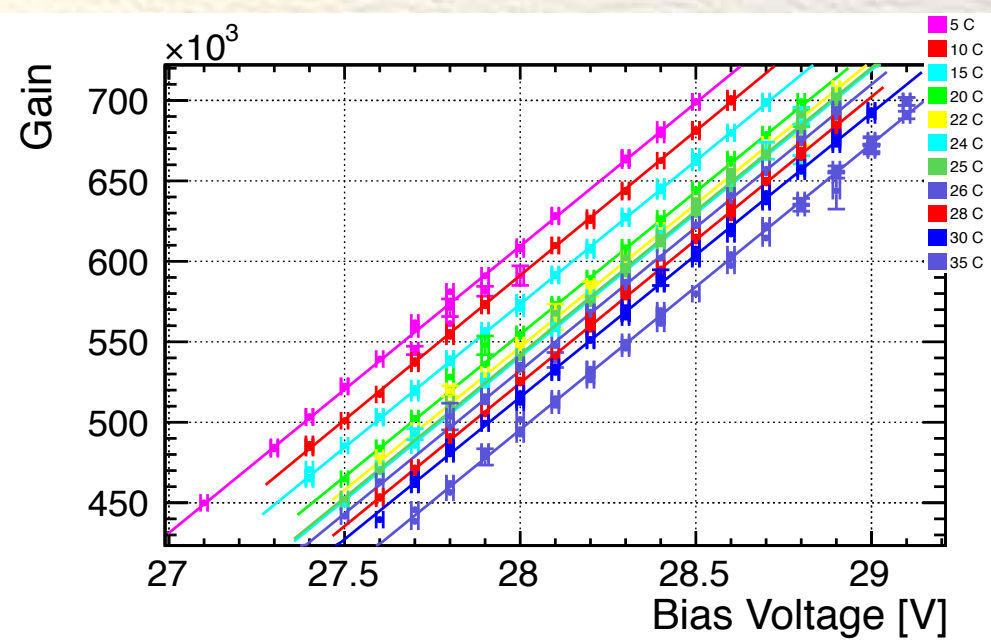
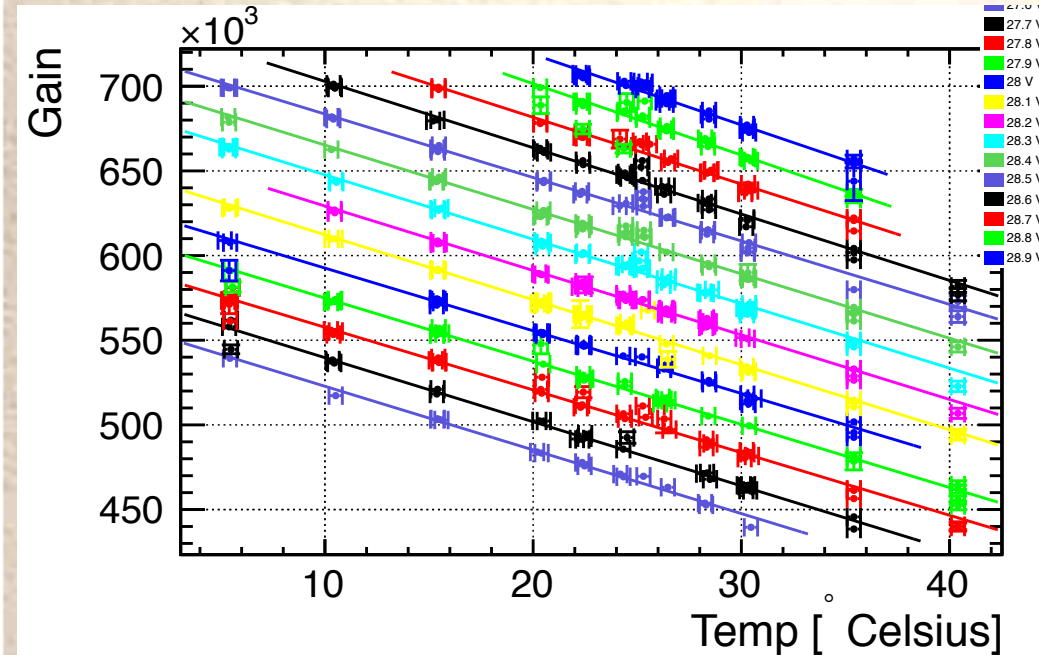
Results for CPTA 1677

- Extract $dV/dT=18.51\pm 0.31$ mV/K and gain stability of 0.1%



Results for KETEK W12

- Extract $dV/dT = 21.29 \pm 0.08$ mV/K and gain stability of 0.01%



Results for Hamamatsu

● Extract $dV/dT=54.3\pm 0.75$ mV/K and gain stability of 0.28%

